Search Notes

Application/C	Application/Control No.		Applicant(s)/Patent under Reexamination	
10/788,542		SCHEER ET A	L.	
Examiner		Art Unit		
Vivian Chen		1773		

SEARCHED					
Class	Subclass	Date	Examiner		
·					

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventor search (PALIN/EXPE)	5/29/2005	VC		
•				